


FEMTOCLOCKS™ CRYSTAL-TO-LVCMOS/LVTTL CLOCK GENERATOR

ICS840001I

GENERAL DESCRIPTION



The ICS840001I is a Fibre Channel Clock Generator and a member of the HiPerClocks™ family of high performance devices from ICS. The ICS840001I uses a 26.5625MHz crystal to synthesize either 106.25MHz or 212.5MHz, using the **FREQ_SEL** pin. The ICS840001I has excellent phase jitter performance, over the 637kHz – 5MHz integration range. The ICS840001I is packaged in a small 8-pin TSSOP, making it ideal for use in systems with limited board space.

FEATURES

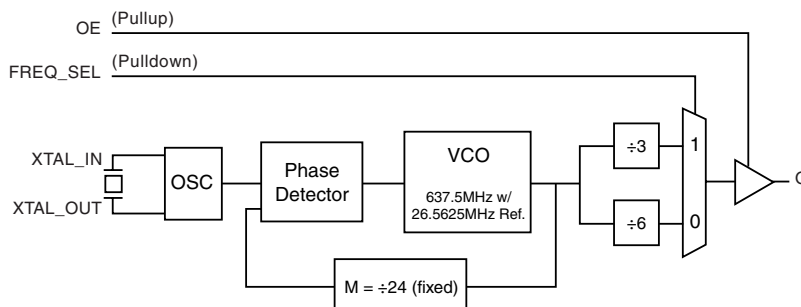
- 1 LVCMOS/LVTTL output, 7Ω typical output impedance
- Crystal oscillator interface designed for 26.5625MHz, 18pF parallel resonant crystal
- Selectable 106.25MHz or 212.5MHz output frequency
- VCO range: 560MHz to 680MHz
- RMS phase jitter @ 106.25MHz, using a 26.5625MHz crystal (637kHz - 5MHz): 0.70ps (typical)
- 3.3V or 2.5V operating supply
- -40°C to 85°C ambient operating temperature

FUNCTION TABLE

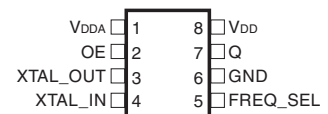
| Input | Output Frequencies |
|----------|---------------------|
| FREQ_SEL | |
| 0 | 106.25MHz (Default) |
| 1 | 212.5MHz |

Crystal: 26.5625MHz

BLOCK DIAGRAM



PIN ASSIGNMENT



ICS840001I

8-Lead TSSOP

4.40mm x 3.0mm x 0.925mm

package body

G Package

Top View

The Preliminary Information presented herein represents a product in prototyping or pre-production. The noted characteristics are based on initial product characterization. Integrated Circuit Systems, Incorporated (ICS) reserves the right to change any circuitry or specifications without notice.

TABLE 1. PIN DESCRIPTIONS

| Number | Name | Type | | Description |
|--------|----------------------|--------|----------|--|
| 1 | V _{DDA} | Power | | Analog supply pin. |
| 2 | OE | Input | Pullup | Output enable pin. When HIGH, Q output is enabled. When LOW, forces Q to HiZ state. LVCMOS/LVTTL interface levels. |
| 3, 4 | XTAL_OUT, XTAL_IN | Input | | Crystal oscillator interface. XTAL_IN is the input. XTAL_OUT is the output. |
| 5 | FREQ_SEL | Input | Pulldown | Frequency select pin. LVCMOS/LVTTL interface levels. |
| 6 | GND | Power | | Power supply ground. |
| 7 | Q | Output | | Single-ended clock output. LVCMOS/LVTTL interface levels. 7Ω typical output impedance. |
| 8 | V _{DD} | Power | | Core supply pin. |

NOTE: *Pullup* and *Pulldown* refer to internal input resistors. See Table 2, Pin Characteristics, for typical values.

TABLE 2. PIN CHARACTERISTICS

| Symbol | Parameter | Test Conditions | Minimum | Typical | Maximum | Units |
|-----------------------|-------------------------------|---|---------|---------|---------|-------|
| C _{IN} | Input Capacitance | | | 4 | | pF |
| C _{PD} | Power Dissipation Capacitance | V _{DD} , V _{DDA} = 3.465V | | TBD | | pF |
| | | V _{DD} , V _{DDA} = 2.625V | | TBD | | pF |
| R _{PULLUP} | Input Pullup Resistor | | | 51 | | kΩ |
| R _{PULLDOWN} | Input Pulldown Resistor | | | 51 | | kΩ |
| R _{OUT} | Output Impedance | | 5 | 7 | 12 | Ω |

TABLE 3. CONTROL FUNCTION TABLE

| Control Inputs | Output |
|----------------|--------|
| OE | Q |
| 0 | Hi-Z |
| 1 | Active |

ABSOLUTE MAXIMUM RATINGS

| | |
|--|--------------------------|
| Supply Voltage, V_{DD} | 4.6V |
| Inputs, V_I | -0.5V to $V_{DD} + 0.5V$ |
| Outputs, V_O | -0.5V to $V_{DD} + 0.5V$ |
| Package Thermal Impedance, θ_{JA} | 101.7°C/W (0 mps) |
| Storage Temperature, T_{STG} | -65°C to 150°C |

NOTE: Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of product at these conditions or any conditions beyond those listed in the *DC Characteristics* or *AC Characteristics* is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

TABLE 4A. POWER SUPPLY DC CHARACTERISTICS, $V_{DD} = V_{DDA} = 3.3V \pm 5\%$, $T_A = -40^\circ\text{C}$ TO 85°C

| Symbol | Parameter | Test Conditions | Minimum | Typical | Maximum | Units |
|-----------|-----------------------|-----------------|---------|---------|---------|-------|
| V_{DD} | Core Supply Voltage | | 3.135 | 3.3 | 3.465 | V |
| V_{DDA} | Analog Supply Voltage | | 3.135 | 3.3 | 3.465 | V |
| I_{DD} | Power Supply Current | | | 75 | | mA |
| I_{DDA} | Analog Supply Current | | | 8 | | mA |

TABLE 4B. POWER SUPPLY DC CHARACTERISTICS, $V_{DD} = V_{DDA} = 2.5V \pm 5\%$, $T_A = -40^\circ\text{C}$ TO 85°C

| Symbol | Parameter | Test Conditions | Minimum | Typical | Maximum | Units |
|-----------|-----------------------|-----------------|---------|---------|---------|-------|
| V_{DD} | Core Supply Voltage | | 2.375 | 2.5 | 2.625 | V |
| V_{DDA} | Analog Supply Voltage | | 2.375 | 2.5 | 2.625 | V |
| I_{DD} | Power Supply Current | | | 73 | | mA |
| I_{DDA} | Analog Supply Current | | | 8 | | mA |

TABLE 4C. LVCMOS/LVTTL DC CHARACTERISTICS, $V_{DD} = V_{DDA} = 3.3V \pm 5\%$ OR $2.5V \pm 5\%$, $T_A = -40^\circ\text{C}$ TO 85°C

| Symbol | Parameter | Test Conditions | Minimum | Typical | Maximum | Units |
|----------|-----------------------------|--|---------|---------|----------------|---------------|
| V_{IH} | Input High Voltage | $V_{DD} = 3.3V$ | 2 | | $V_{DD} + 0.3$ | V |
| | | $V_{DD} = 2.5V$ | 1.7 | | $V_{DD} + 0.3$ | V |
| V_{IL} | Input Low Voltage | $V_{DD} = 3.3V$ | -0.3 | | 0.8 | V |
| | | $V_{DD} = 2.5V$ | -0.3 | | 0.7 | V |
| I_{IH} | Input High Current | FREQ_SEL $V_{DD} = V_{IN} = 3.465V$ or $2.625V$ | | | 150 | μA |
| | | OE $V_{DD} = V_{IN} = 3.465V$ or $2.625V$ | | | 5 | μA |
| I_{IL} | Input Low Current | FREQ_SEL $V_{DD} = 3.465V$ or $2.625V$, $V_{IN} = 0V$ | -5 | | | μA |
| | | OE $V_{DD} = 3.465V$ or $2.625V$, $V_{IN} = 0V$ | -150 | | | μA |
| V_{OH} | Output High Voltage; NOTE 1 | $V_{DD} = 3.465V$ | 2.6 | | | V |
| | | $V_{DD} = 2.625V$ | 1.8 | | | V |
| V_{OL} | Output Low Voltage; NOTE 1 | $V_{DD} = 3.465V$ or $2.625V$ | | | 0.5 | V |

NOTE 1: Outputs terminated with 50Ω to $V_{DD}/2$. See Parameter Measurement Information Section, "Output Load Test Circuit" diagrams.

TABLE 5. CRYSTAL CHARACTERISTICS

| Parameter | Test Conditions | Minimum | Typical | Maximum | Units |
|------------------------------------|-----------------|-------------|---------|---------|----------|
| Mode of Oscillation | | Fundamental | | | |
| Frequency | | | 26.5625 | | MHz |
| Equivalent Series Resistance (ESR) | | | | 50 | Ω |
| Shunt Capacitance | | | | 7 | pF |
| Drive Level | | | | 1 | mW |

TABLE 6A. AC CHARACTERISTICS, $V_{DD} = V_{DDA} = 3.3V \pm 5\%$, $T_A = -40^\circ\text{C}$ TO 85°C

| Symbol | Parameter | Test Conditions | Minimum | Typical | Maximum | Units |
|----------------------|--------------------------------------|---|---------|---------|---------|-------|
| f_{OUT} | Output Frequency | FREQ_SEL = 1 | 186.66 | 212.5 | 226.66 | MHz |
| | | FREQ_SEL = 0 | 93.33 | 106.25 | 113.33 | MHz |
| $f_{jit}(\emptyset)$ | RMS Phase Jitter (Random); NOTE 1 | $f_{OUT} = 106.25\text{MHz}$, (637kHz to 5MHz) | | 0.70 | | ps |
| | | $f_{OUT} = 212.5\text{MHz}$, (2.55MHz to 20MHz) | | 0.50 | | ps |
| t_R / t_F | Output Rise/Fall Time | 20% to 80% | | 400 | | ps |
| odc | Output Duty Cycle | | | 50 | | % |

All parameters are characterized @ 212.5MHz and 106.25MHz.

NOTE 1: Please refer to the Phase Noise Plots following this section.

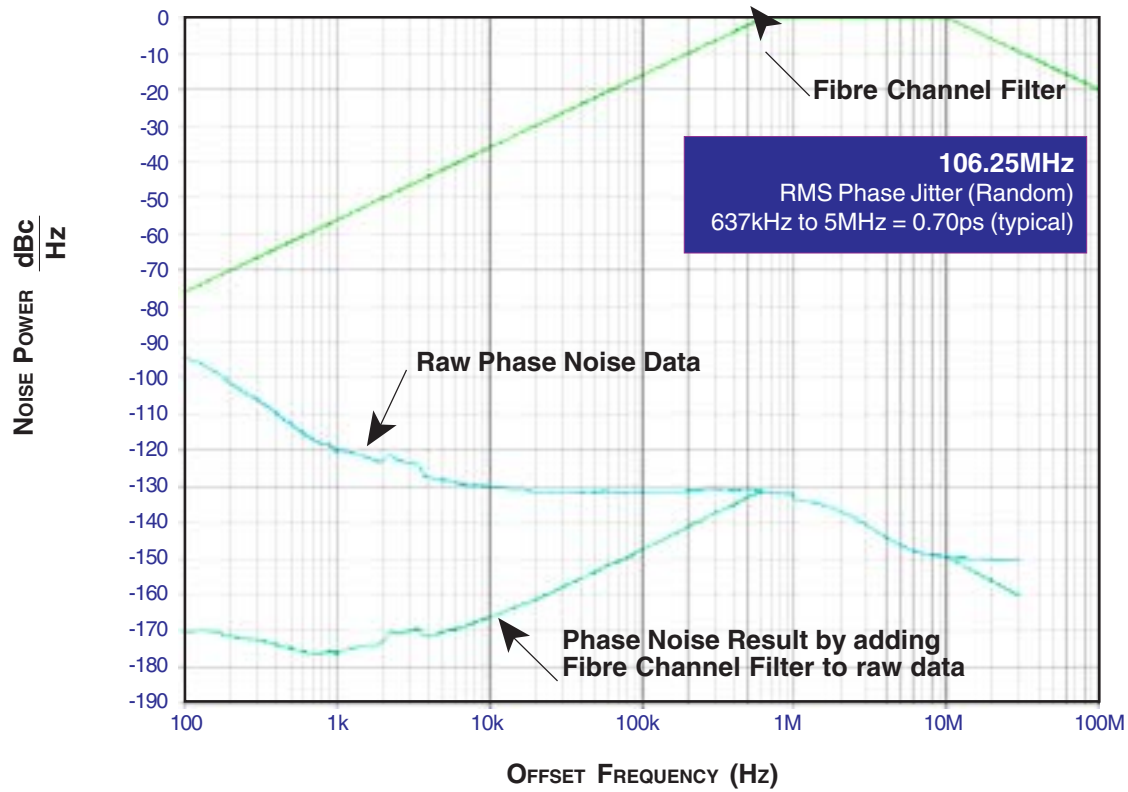
TABLE 6B. AC CHARACTERISTICS, $V_{DD} = V_{DDA} = 2.5V \pm 5\%$, $T_A = -40^\circ\text{C}$ TO 85°C

| Symbol | Parameter | Test Conditions | Minimum | Typical | Maximum | Units |
|----------------------|--------------------------------------|---|---------|---------|---------|-------|
| f_{OUT} | Output Frequency | FREQ_SEL = 1 | 186.66 | 212.5 | 226.66 | MHz |
| | | FREQ_SEL = 0 | 93.33 | 106.25 | 113.33 | MHz |
| $f_{jit}(\emptyset)$ | RMS Phase Jitter (Random); NOTE 1 | $f_{OUT} = 106.25\text{MHz}$, (637kHz to 5MHz) | | 0.70 | | ps |
| | | $f_{OUT} = 212.5\text{MHz}$, (2.55MHz to 20MHz) | | 0.50 | | ps |
| t_R / t_F | Output Rise/Fall Time | 20% to 80% | | 450 | | ps |
| odc | Output Duty Cycle | | | 50 | | % |

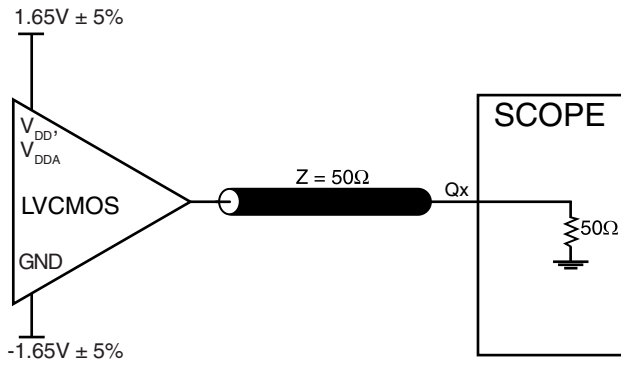
All parameters are characterized @ 212.5MHz and 106.25MHz.

NOTE 1: Please refer to the Phase Noise Plots following this section.

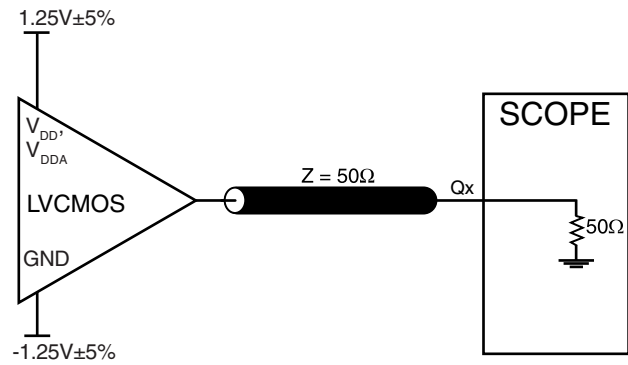
TYPICAL PHASE NOISE AT 106.25MHz



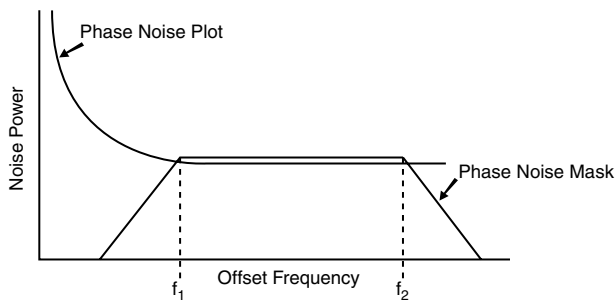
PARAMETER MEASUREMENT INFORMATION



3.3V OUTPUT LOAD AC TEST CIRCUIT

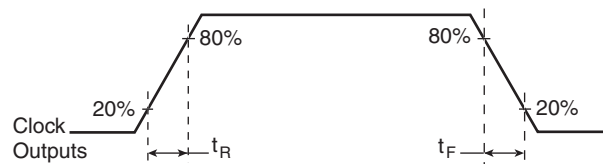


2.5V OUTPUT LOAD AC TEST CIRCUIT

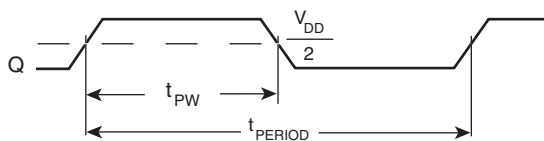


$$\text{RMS Jitter} = \sqrt{\text{Area Under the Masked Phase Noise Plot}}$$

RMS PHASE JITTER



OUTPUT RISE/FALL TIME



$$\text{odc} = \frac{t_{PW}}{t_{PERIOD}} \times 100\%$$

OUTPUT DUTY CYCLE/PULSE WIDTH/PERIOD

APPLICATION INFORMATION

POWER SUPPLY FILTERING TECHNIQUES

As in any high speed analog circuitry, the power supply pins are vulnerable to random noise. The ICS840001I provides separate power supplies to isolate any high switching noise from the outputs to the internal PLL. V_{DD} and V_{DDA} should be individually connected to the power supply plane through vias, and bypass capacitors should be used for each pin. To achieve optimum jitter performance, power supply isolation is required. *Figure 1* illustrates how a 10Ω resistor along with a $10\mu\text{F}$ and a $.01\mu\text{F}$ bypass capacitor should be connected to each V_{DDA} pin.

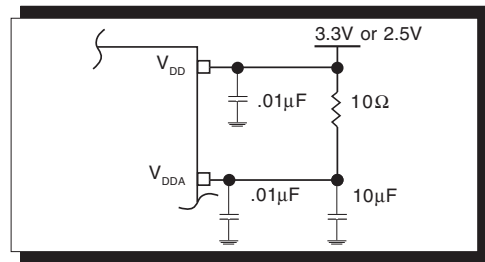


FIGURE 1. POWER SUPPLY FILTERING

CRYSTAL INPUT INTERFACE

The ICS840001I has been characterized with 18pF parallel resonant crystals. The capacitor values, C1 and C2, shown in *Figure 2* below were determined using a 26.5625MHz, 18pF par-

allel resonant crystal and were chosen to minimize the ppm error. The optimum C1 and C2 values can be slightly adjusted for different board layouts.

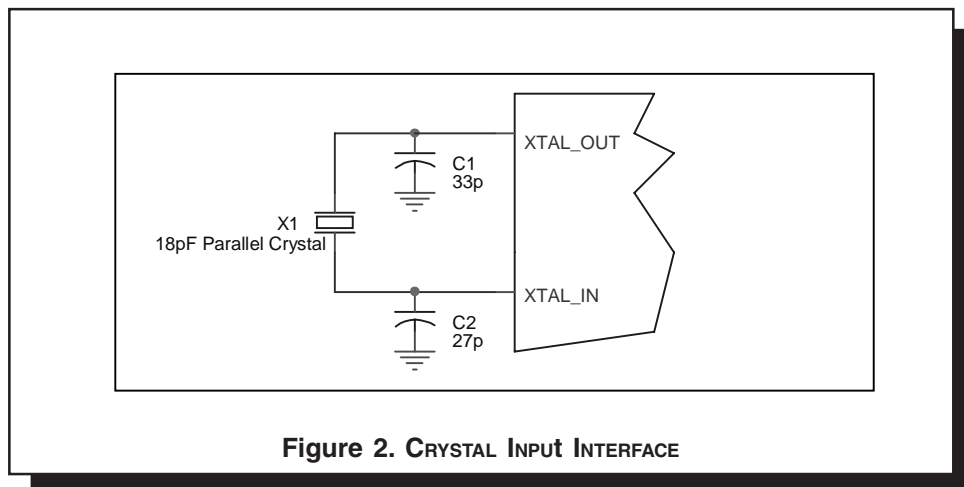


Figure 2. CRYSTAL INPUT INTERFACE

LAYOUT GUIDELINE

Figure 3A shows a schematic example of the ICS840001I. An example of LVCMOS termination is shown in this schematic. Additional LVCMOS termination approaches are shown in the LVCMOS Termination Application Note. In this example, an 18 pF parallel resonant 26.5625MHz crystal is used. The C1=27pF and C2=33pF are recommended for frequency accuracy. For

different board layout, the C1 and C2 may be slightly adjusted for optimizing frequency accuracy. The output frequency can be set at either 106.25MHz or 212.5MHz. Leaving the R1 un-installed (or install 1k Ω pull-down) will set the output frequency at 106.25MHz. Installing the R1 pull up will set the output frequency at 212.5MHz.

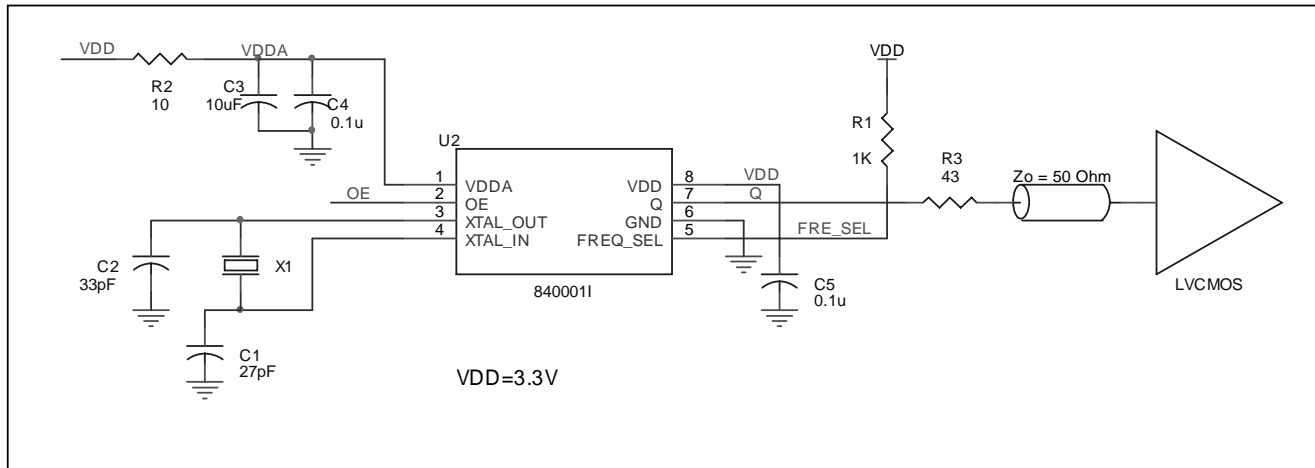


FIGURE 3A. ICS840001I SCHEMATIC EXAMPLE

PC BOARD LAYOUT EXAMPLE

Figure 3B shows an example of P.C. board layout. The crystal X1 footprint in this example allows either surface mount (HC49S) or through hole (HC49) package. C3 is 0805. C1 and C2 are

0402. Other resistors and capacitors are 0603. This layout assumes that the board has clean analog power and ground planes.

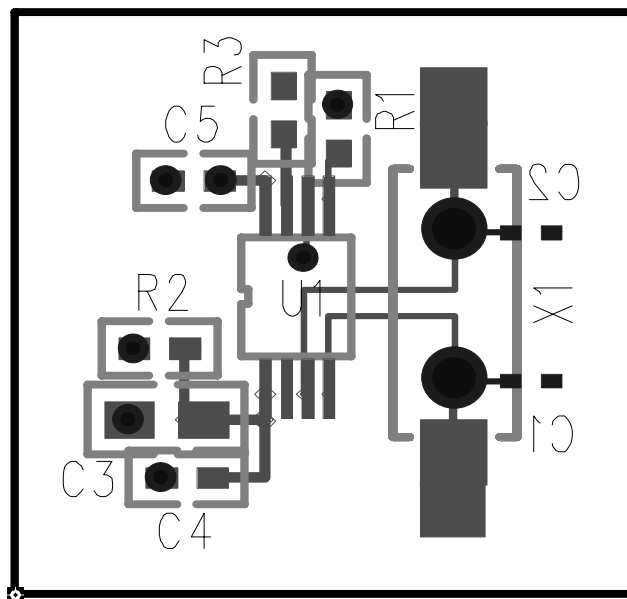


FIGURE 3B. ICS840001I PC BOARD LAYOUT EXAMPLE

RELIABILITY INFORMATION

TABLE 7. θ_{JA} VS. AIR FLOW TABLE FOR 8 LEAD TSSOP

| θ_{JA} by Velocity (Meters Per Second) | | | |
|---|-----------|----------|----------|
| | 0 | 1 | 2.5 |
| Multi-Layer PCB, JEDEC Standard Test Boards | 101.7°C/W | 90.5°C/W | 89.8°C/W |

TRANSISTOR COUNT

The transistor count for ICS8400011 is: 1521

PACKAGE OUTLINE - G SUFFIX FOR 8 LEAD TSSOP

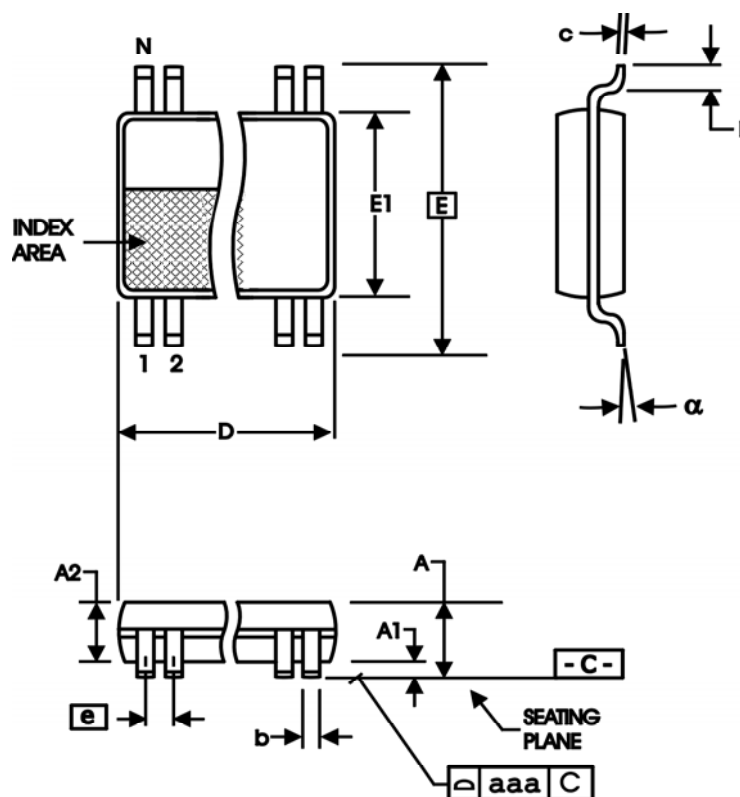


TABLE 8. PACKAGE DIMENSIONS

| SYMBOL | Millimeters | |
|----------|-------------|---------|
| | Minimum | Maximum |
| N | 8 | |
| A | -- | 1.20 |
| A1 | 0.05 | 0.15 |
| A2 | 0.80 | 1.05 |
| b | 0.19 | 0.30 |
| c | 0.09 | 0.20 |
| D | 2.90 | 3.10 |
| E | 6.40 BASIC | |
| E1 | 4.30 | 4.50 |
| e | 0.65 BASIC | |
| L | 0.45 | 0.75 |
| α | 0° | 8° |
| aaa | -- | 0.10 |

Reference Document: JEDEC Publication 95, MO-153

TABLE 9. ORDERING INFORMATION

| Part/Order Number | Marking | Package | Shipping Packaging | Temperature |
|-------------------|---------|--------------|--------------------|---------------|
| ICS840001AGI | 001AI | 8 lead TSSOP | tube | -40°C to 85°C |
| ICS840001AGIT | 001AI | 8 lead TSSOP | 2500 tape & reel | -40°C to 85°C |

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